

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/676,707	<b>Applicant(s)/Patent under Reexamination</b> TOM-MOY ET AL.
	<b>Examiner</b> Christopher L. Chin	<b>Art Unit</b> 1641

**SEARCHED**

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner